

FACULTY OF ENGINEERING OFFICE OF THE DEAN



COURSE / MODULE / BLOCK DETAILS ACADEMIC YEAR / SEMESTER

Offered by:					
Metalurji ve	e Malzeme Müher	ndisliği			
Course Title	•:		Course Org. Title:		
MATERIALS CHARACTERIZATION		8	MATERIALS CHARACTERIZATION		
Course Level:			Course Code:		
Lisans			MME 2408		
LISANS					
Language of Instruction:			Form Submitting/Renewal Date		
İngilizce			14/05/2014		
Weekly Cours	e Hours:		Course Coordinator:		
5			DOÇENT ALİ BÜLENT ÖNAY		
Theory	Application	Laboratory	National Credit:		
			4		
3	2	0	ECTS Credit:		
			6		

Wire: 0 232 301 72 15

Fax: 0 232 301 72 10

Address: Dokuz Eylül Üniversitesi Tınaztepe Yerleşkesi 35160 Buca/İZMİR E-mail: muhendislik@deu.edu.tr



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Offered to:

Course Status: Compulsory/Elective

Name of the Department:

Metallurgical And Materials Engineering

Required Course

Wire: 0 232 301 72 15

Fax: 0 232 301 72 10

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Instructor/s:

Wire: 0 232 301 72 15

Fax: 0 232 301 72 10

Address: Dokuz Eylül Üniversitesi Tınaztepe Yerleşkesi 35160 Buca/İZMİR E-mail: muhendislik@deu.edu.tr



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Course Objective:

To introduce equipments and techniques used to determine the internal structure as well as the physical and chemical properties (characterization) of engineering materials, while at the same time conduct related applications.

Learning Outcomes:

- To be able to understand and gain experience on the use of optical microscopy and metallographic preparation of metallurgical samples
 To be able to explain the structure, operating techniques and applications of the Scanning Electron Microscope
- 3 To be able to explain the production, properties and use of X-rays in materials characterization
- 4 To be able to explain the working principals of the thermal analysis equipment and interpret the application results
- 5 To be able to recognize the techniques used for chemical characterization of materials and interpret the application results
- 6 To be able to conduct the applications and report their results as teams
- 7 To be able to identify the use of the characteriztion equipment in solving materials problems as well in developing new materials

Learning and Teaching Strategies:

Lectures + Applications + Report writing + Group studies +Midterm exams + Final exam

Assessment Methods:		
Name	Code	Calculation formula
1.Vize	VZ1	
2.Vize	VZ2	
Lab	LB	
Final	FN	
Bütünleme Notu	BUT	
BNS	BNS	VZ1 * 015 + VZ2 * 015 + LB * 020 + FN * 050
Bütünleme Sonu Başarı Notu	BBN	VZ1 * 015 + VZ2 * 015 + LB * 020 + BUT * 050

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Further Notes about Assessment Methods:

Textbook(s)/References/Materials:

Application studies and report writing are conducted by groups. These activities have a total weight of 20% in grading. Nonparticipation in these activites is graded individually.

Assessment Criteria:

Learning	Outcomes		As	ssessment			
	1 - 7	Midterm	exams,	applications,	report	writing,	Final
exam							

Textbook(s): 1. Encyclopedia of Materials Characterizations, Lee E. Fitzpatrick, Butterworth-Heinemann, Butterworth-Hei, USA, 1992, 2. Scanning Electron Microscopy and X-ray Microanalysis, J. Goldstein, D. E. Newbury, D.C. Joy, Springer Verlag, 0306472929 ,USA 3. Elements of X-Ray Diffraction, B.D. Cullity, Addison Wesley Publishing Company, 0201 01230 8, USA,1967

References: Journals related to materials characterization studies 1. ASM Handbook, Metallography and Microstructures, vol.9. 2. Microscopy Techniques for Materials Science, AR Clarke, CN Eberhard, Woodhead Publishing Ltd., 1-85573-587-3, England,2002 3. Fundamentals of Light Microscopy and Electronic Imaging, Douglas B Murphy, Wiley&Sons, 0-471-25391-X, Canada, 2001

Other references: 1.Reports and regular publications on materials characterization 2.Manuals and other written or visual material published by the equipment makers

Course Policies and Rules:

Wire: 0 232 301 72 15



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Contact Details for the Instructor:

Ali Bülent ÖNAY (bulent.onay@deu.edu.tr), Ahmet ÇAKIR (ahmet.cakir@deu.edu.tr)

Office Hours:

Monday 9:30 - 10:30

Course	Outline:	
Week	Topics:	Notes:
1	Introduction to metallographic sample	Selection of materials for
	<pre>preparation(SP): Cutting, molding and mold materials</pre>	, applications
	grinding and polishing	
2	Introduction to metallographic sample preparation:	Indentification of
	Electrolytical polishing principles and etching	characterization methods
	techniques	
3	Mictrostructure analysis of materials by an optical	1.Application SP ve OM
	microscope (OM): Parts of the microscope,	
	investigation of lenses and lens defects.	
4	Mictrostructure analyses of materials by an optical	2. SP and OM
	microscope: illumination systems, magnification and	
	working principles of the microscope	
5	Investigation by an optical microscope, of the	3. SP and OM
	microstructures of materials produced by different	
	methods	
6	Preparation of heat treated samples and their optical	14. SP and OM
	microscope analyses	
7	1st midterm	
8	Material-electron interactions and material	5. SEM
	characterization by Scanning Electron Microscope	
	(SEM)	
9	Material characterization by XRD	6. XRD
10	Material characterization by XRF	7. XRF
11	2nd midterm	
12	Characterization of thermal properties by TGA / DTA	8.TGA and DTA
13	Characterization of materials by the FTIR method	9.FTIR

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14 Introduction to OES and some other characterization 10. Related applications methods



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ECTS Table

Course Activities	Number	Duration (hour)	Total Work Load (hour)
In Class Activities			
Lectures	12	3	36
Applications (Lab)	10	2	20

Exams			
Midterm	2	2	4
Final	1	2	2

Out Class activities				
Preparations before/after weekly lectures		3	36	
Preparation for midterm exam	2	4	8	
Preparation for final exam	1	5	5	
Preparing the application reports	10	5	50	
Total Work Load (hour)			161	
ECTS Credits of the Course= Total Work Load (hour) / 25			6	